



SEARCHED

Class	Sub.	Date	Exmr.
714	724	9/26/03	JH
714	all	9/29/03	JH

INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	Date	Exmr.
All classes and tester & scan & flips or registers and feedback Hapke. 17. IEEE, 10 SPEC, Iterative Logic Analysis	9/29/03	JH
	9/29/03	JH
	9/29/03	JH

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